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- 3-State Buffer-Type Outputs Drive Bus Lines Directly
- Bus-Structured Pinout
- Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK), and Plastic (NT) and Ceramic (JT) DIPs

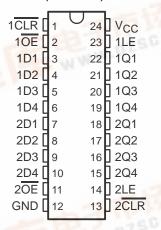
description

These dual 4-bit D-type latches feature 3-state outputs designed specifically for bus driving. These devices are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

The dual 4-bit latches are transparent D-type latches. While the latch-enable (LE) input is high, the Q outputs follow the data (D) inputs in true form, according to the function table. When LE is low, the outputs are latched. When the clear (CLR) input goes low, the Q outputs go low independently of LE. The outputs are in the high-impedance state when the output-enable (OE) input is at a high logic level.

The SN54ALS873B and SN54AS873A are characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS873B and SN74AS873A are characterized for operation from 0°C to 70°C.

SN54ALS873B, SN54AS873A . . . JT PACKAGE SN74ALS873B, SN74AS873A . . . DW OR NT PACKAGE (TOP VIEW)



SN54ALS873B, SN54AS873A . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

FUNCTION TABLE (each latch)

	INPU	JTS		OUTPUT
OE	CLR	LE	D	Q
L	L	Χ	Χ	L
L	Н	Н	Н	Н
L	Н	Н	L	L
4	C OHA	L	Χ	Q ₀
Н	Χ	Х	Χ	Z



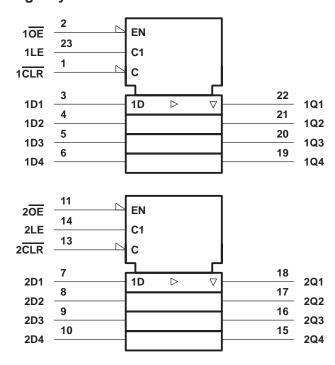
SN54ALS873B, SN54AS873A, SN74ALS873B, SN74AS873A

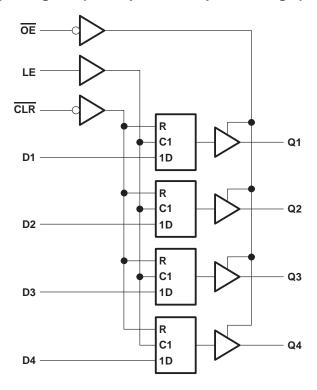
DUAL 4-BIT D-TYPE LATCHES WITH 3-STATE OUTPUTS

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logic symbol†

logic diagram (each quad latch, positive logic)





[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the DW, JT, and NT packages.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V _{CC}	7 V
Input voltage, V _I	
Voltage applied to a disabled 3-state output	
Operating free-air temperature range, T _A : SN54ALS873B	−55°C to 125°C
SN74ALS873B	0°C to 70°C
Storage temperature range	-65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

		SN54ALS873B SN74ALS873B			'3B	UNIT		
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
V _{IL}	Low-level input voltage			0.7			0.8	V
IOH	High-level output current			-1			-2.6	mA
l _{OL}	Low-level output current			12			24	mA
TA	Operating free-air temperature	-55		125	0		70	°C



SN54ALS873B, SN54AS873A, SN74ALS873B, SN74AS873A DUAL 4-BIT D-TYPE LATCHES WITH 3-STATE OUTPUTS

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST C	ONDITIONS	SN	54ALS87	'3B	SN7	4ALS87	3B	UNIT
PARAMETER	IESI C	ONDITIONS	MIN	TYP†	MAX	MIN	TYP	MAX	UNII
VIK	$V_{CC} = 4.5 \text{ V},$	$I_{I} = -18 \text{ mA}$			-1.2			-1.2	V
	V _{CC} = 4.5 V to 5.5 V,	$I_{OH} = -0.4 \text{ mA}$	V _{CC} -2	2		VCC-2	2		
Voн	V 45 V	I _{OH} = -1 mA	2.4	3.3					V
	V _{CC} = 4.5 V	$I_{OH} = -2.6 \text{ mA}$				2.4	3.2		
V	V 45V	I _{OL} = 12 mA		0.25	0.4		0.25	0.4	_ \
VOL	V _{CC} = 4.5 V	I _{OL} = 24 mA					0.35	0.5	V
lozh	$V_{CC} = 5.5 V,$	V _O = 2.7 V			20			20	μΑ
lozL	$V_{CC} = 5.5 V,$	V _O = 0.4 V			-20			-20	μΑ
lį	$V_{CC} = 5.5 V,$	V _I = 7 V			0.1			0.1	mA
lін	V _{CC} = 5.5 V,	V _I = 2.7 V			20			20	μΑ
I _{IL}	V _{CC} = 5.5 V,	V _I = 0.4 V			- 0.2			- 0.2	mA
1 ₀ ‡	$V_{CC} = 5.5 \text{ V},$	V _O = 2.25 V	-20		-112	-30		-112	mA
		Outputs high		11	21		11	21	
Icc	V _{CC} = 5.5 V	Outputs low		16	29		16	29	mA
		Outputs disabled		20	31		20	31	

 $[\]uparrow$ All typical values are at V_{CC} = 5 V, T_A = 25°C.

timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

			SN54AL	S873B	SN74AL	UNIT	
			MIN	MAX	MIN	MAX	UNIT
	Pulse duration	CLR low	15		15		no
t _W	ruise dui attori	MIN MAX MIN MAX U Ition CLR low 15 15 15 LE high 10 10 10 10 e, data before LE↓ 10 10 10 10	ns				
t _{su}	Setup time, data before LE↓		10		10		ns
th	Hold time, data after LE↓		7		7		ns

[‡] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, los.

SN54ALS873B, SN54AS873A, SN74ALS873B, SN74AS873A DUAL 4-BIT D-TYPE LATCHES WITH 3-STATE OUTPUTS

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switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	CL R1: R2:	C = 4.5 V = 50 pF, = 500 Ω, = 500 Ω, = MIN to			UNIT
			SN54AL	S873B	SN74AL	S873B	
			MIN	MAX	MIN	MAX	
t _{PLH}	D	Q	2	23	2	14	ns
^t PHL		Q .	2	17	2	14	115
t _{PLH}	LE	Q	8	31	8	22	ns
^t PHL		ų .	8	26	8	21	115
t _{PHL}	CLR	Q	6	27	6	20	ns
^t PZH	ŌĒ	Q	4	24	4	18	ns
t _{PZL}	OE .		4	23	4	18	115
^t PHZ	ŌĒ	Q	2	12	2	10	ns
t _{PLZ}	OL	<u> </u>	2	30	2	15	113

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V _{CC}	7 V
Input voltage, V _I	7 V
Voltage applied to a disabled 3-state output	
Operating free-air temperature range, T _A : SN54AS873A	-55°C to 125°C
SN74AS873A	0°C to 70°C
Storage temperature range	-65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

		SN	54AS873	ВА	SN74AS873A			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
V _{IL}	Low-level input voltage			0.8			0.8	V
ІОН	High-level output current			-12			-15	mA
loL	Low-level output current			32			48	mA
TA	Operating free-air temperature	-55		125	0		70	°C



SN54ALS873B, SN54AS873A, SN74ALS873B, SN74AS873A DUAL 4-BIT D-TYPE LATCHES WITH 3-STATE OUTPUTS

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST C	ONDITIONS	SN54AS873A		3A	SN	74AS87	BA UNIT	
PARAMETER	TEST C	ONDITIONS	MIN	TYP†	MAX	MIN	TYP†	MAX	UNIT
VIK	$V_{CC} = 4.5 \text{ V},$	I _I = -18 mA			-1.2			-1.2	V
	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -2 \text{ mA}$	Vcc-2	2		VCC-2	2		
Vон	V _{CC} = 4.5 V	$I_{OH} = -12 \text{ mA}$	2.4	3.2					V
	VCC = 4.5 V	$I_{OH} = -15 \text{ mA}$				2.4	3.3		
V	V 45V	I _{OL} = 32 mA		0.25	0.5				V
VOL	V _{CC} = 4.5 V	I _{OL} = 48 mA					0.35	0.5	
lozh	$V_{CC} = 5.5 V,$	V _O = 2.7 V			50			50	μΑ
lozL	V _{CC} = 5.5 V,	V _O = 0.4 V			-50			-50	μΑ
IĮ	V _{CC} = 5.5 V,	V _I = 7 V			0.1			0.1	mA
lін	V _{CC} = 5.5 V,	V _I = 2.7 V			20			20	μΑ
I _{IL}	V _{CC} = 5.5 V,	V _I = 0.4 V			- 0.5			- 0.5	mA
IO [‡]	$V_{CC} = 5.5 \text{ V},$	V _O = 2.25 V	-30		-112	-30		-112	mA
		Outputs high		68	110		68	110	
ICC	V _{CC} = 5.5 V	Outputs low		67	109		67	109	mA
		Outputs disabled		80	129		80	129	

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

			SN54AS	873A	SN74AS	UNIT	
		CLR low LE high	MIN	MAX	MIN	MAX	Oitii
. *	Pulse duration	R low	5		5		ns
t _W *	LE high		6		5		115
t _{su} *	t _{Su} * Setup time, data before LE↓		2		2		ns
th*	Hold time, data after LE↓		4.5		4.5		ns

^{*} On products compliant to MIL-STD-883, Class B, this parameter is based on characterization data but is not production tested.

[‡] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I_{OS}.

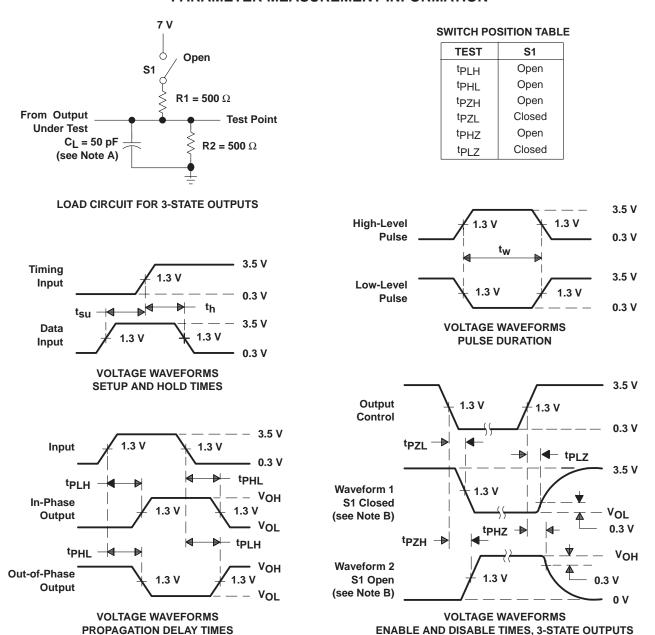
SN54ALS873B, SN54AS873A, SN74ALS873B, SN74AS873A DUAL 4-BIT D-TYPE LATCHES WITH 3-STATE OUTPUTS SDAS036D - APRIL 1982 - REVISED AUGUST 1995

switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	C _L R1 R2	= 50 pl = 500 c 2 = 500 c	2,		UNIT
			SN54A	S873A	SN74A	S873A	
		ļ	MIN	MAX	MIN	MAX	
t _{PLH}	D	Q	3	12.5	3	9.5	ns
^t PHL		ά	3	8.5	3	7.5	115
t _{PLH}	LE	Q	6	15.5	6	13	ns
^t PHL		ά	4	9	4	7.5	115
t _{PHL}	CLR	Q	3	10.5	3	9	ns
^t PZH	ŌĒ	Q	2	8	2	6.5	20
t _{PZL}	OE	ν	4	11	4	10.5	ns
t _{PHZ}	ŌĒ	Q	2	8	2	7.5	ns
t _{PLZ}	OE .	ų ,	2	8.5	2	7.5	115

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \ \Omega$, $t_f \leq$ 2 ns. $t_f \leq$ 2 ns.
- D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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